Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/007,142	MAGEE ET AL.	
Examiner	Art Unit	
Erin M. File	2634	

SEARCHED					
Class	Subclass	Date	Examiner		
375	262	1/11/2005	EMF		
370	339	1/12/2005	EMF		
370	442	1/13/2005	EMF		

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
375	262	1/11/2005	EMF		
375	261	1/11/2005	EMF		

SEARCH NOT (INCLUDING SEARCH))
	DATE	EXMR
EAST US PAT, USPGPUB, EPO, JPO DERWENT, IBM	1/12/2005	EMF
PALM INVENTORSHIP	1/10/2005	EMF